

Notice of References Cited	Application/Control No. 10/799,096	Applicant(s)/Patent Under Reexamination BECKER, CLARK	
	Examiner Uyen-Chau N. Le	Art Unit 2876	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,987,612 A	11-1999	Takagawa et al.	726/9
*	B	US-2001/0025253 A1	09-2001	Heintz et al.	705/14
*	C	US-2004/0091111 A1	05-2004	Levy et al.	380/202
*	D	US-6,738,901 B1	05-2004	Boyles et al.	713/159
*	E	US-6,934,841 B2	08-2005	Boyles et al.	713/159
*	F	US-7,111,051 B2	09-2006	Nobakht et al.	709/217
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2003208410 A	07-2003	Japan	SAITO, KENICHIRO	
	O	KR 2005052949 A	06-2005	Korea, Republic	ROH, H G	
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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